

# International IR Rectifier

PD - 97056

## IRF4000

HEXFET® Power MOSFET

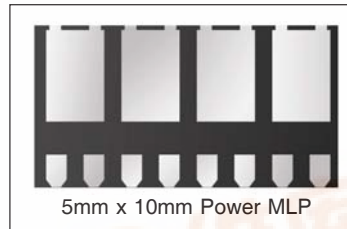
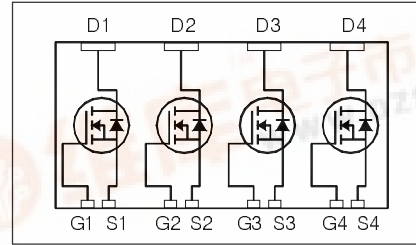
### Applications

- IEEE 802.3af Compliant PoE Switch in Power Sourcing Equipment

### Features

- Exceeds IEEE 802.3af PoE requirements
- Rugged planar technology with large SOA
- Very Low Leakage at 100V (1.5µA max)
- Fully characterized avalanche voltage and current
- Thermally enhanced
- Saves space: replaces 4 discrete MOSFETs

V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
100V	270mΩ @ V <sub>GS</sub> = 12V	2.4A
	350mΩ @ V <sub>GS</sub> = 10V	



### Absolute Maximum Ratings

	Parameter	Max.	Units
V <sub>DS</sub>	Drain-to-Source Voltage	100	V
V <sub>GS</sub>	Gate-to-Source Voltage	± 30	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	2.4	A
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	1.9	
I <sub>DM</sub>	Pulsed Drain Current ①	19	
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Maximum Power Dissipation	3.5	W
	Linear Derating Factor	0.028	W/°C
dv/dt	Peak Diode Recovery dv/dt	8.6	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 150	°C
T <sub>STG</sub>	Storage Temperature Range		

### Thermal Resistance

	Parameter	Typ.	Max.	Units
R <sub>θJL</sub>	Junction-to-Drain Lead	—	1.5	°C/W
R <sub>θJA</sub>	Junction-to-Ambient (PCB Mount) ④	—	36	

Notes ① through ⑤ are on page 7  
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### Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.19	—	V/°C	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$ ③
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	230	270	mΩ	$V_{GS} = 12V, I_D = 2.4A$ ③
		—	270	350		$V_{GS} = 10V, I_D = 2.4A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	3.5	—	5.7	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	1.5	μA	$V_{DS} = 100V, V_{GS} = 0V$
		—	—	10		$V_{DS} = 80V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 30V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -30V$

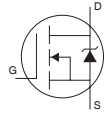
### Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
gfs	Forward Transconductance	1.6	—	—	S	$V_{DS} = 25V, I_D = 1.4A$
$Q_g$	Total Gate Charge	—	9.4	14	nC	$I_D = 1.4A$
$Q_{gs}$	Gate-to-Source Charge	—	2.8	4.2		$V_{DS} = 80V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	4.5	6.8		$V_{GS} = 10V$ ⑤
$t_{d(on)}$	Turn-On Delay Time	—	8.7	—	ns	$V_{DD} = 50V$
$t_r$	Rise Time	—	1.5	—		$I_D = 1.4A$
$t_{d(off)}$	Turn-Off Delay Time	—	13	—		$R_G = 6.2\Omega$
$t_f$	Fall Time	—	6.1	—		$V_{GS} = 10V$ ③
$C_{iss}$	Input Capacitance	—	330	—	pF	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	—	77	—		$V_{DS} = 25V$
$C_{riss}$	Reverse Transfer Capacitance	—	18	—		$f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	—	410	—		$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	—	45	—		$V_{GS} = 0V, V_{DS} = 80V, f = 1.0\text{MHz}$
$C_{oss\ eff.}$	Effective Output Capacitance	—	89	—		$V_{GS} = 0V, V_{DS} = 0V\ \text{to}\ 80V$

### Avalanche Characteristics

	Parameter	Typ.	Max.	Units
$E_{AS}$	Single Pulse Avalanche Energy ②	—	8.7	mJ
$I_{AR}$	Avalanche Current ①	—	1.4	A

### Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	3.2	A	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	19		
$V_{SD}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 1.4A, V_{GS} = 0V$ ③
$t_{rr}$	Reverse Recovery Time	—	67	100	ns	$T_J = 25^\circ\text{C}, I_F = 1.4A, V_{DD} = 25V$
$Q_{rr}$	Reverse Recovery Charge	—	180	270	nC	$di/dt = 100A/\mu s$ ③
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

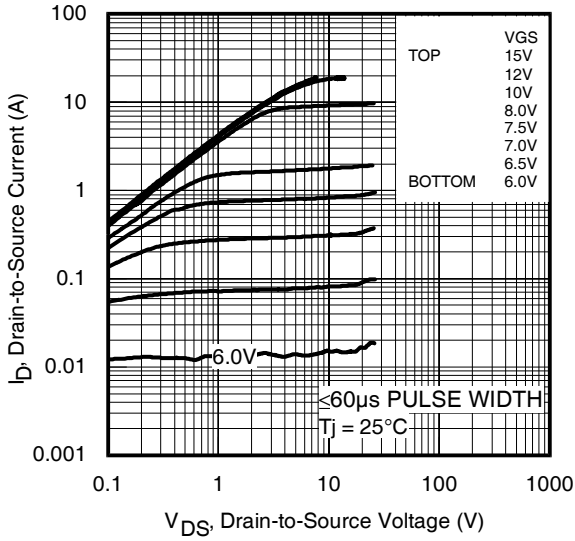


Fig 1. Typical Output Characteristics

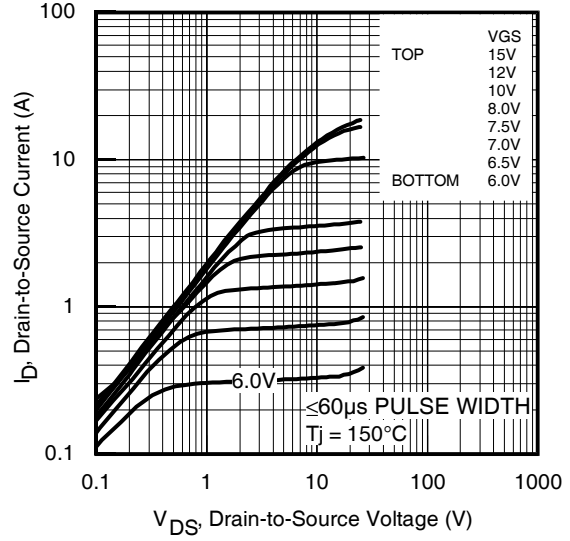


Fig 2. Typical Output Characteristics

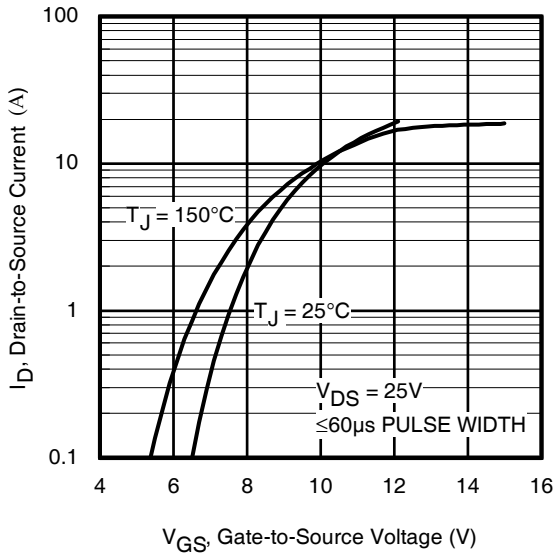


Fig 3. Typical Transfer Characteristics

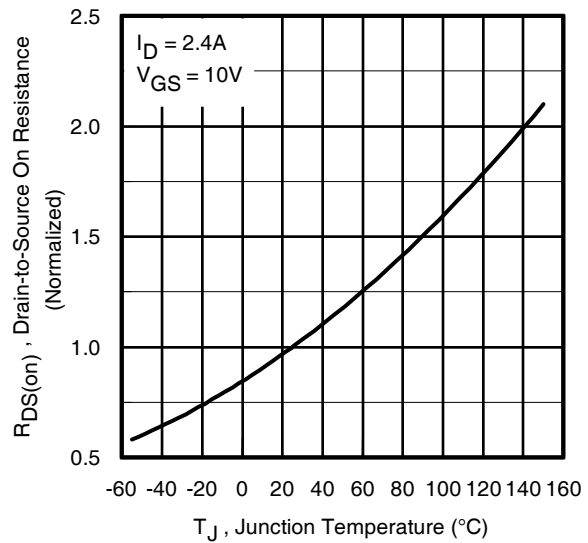
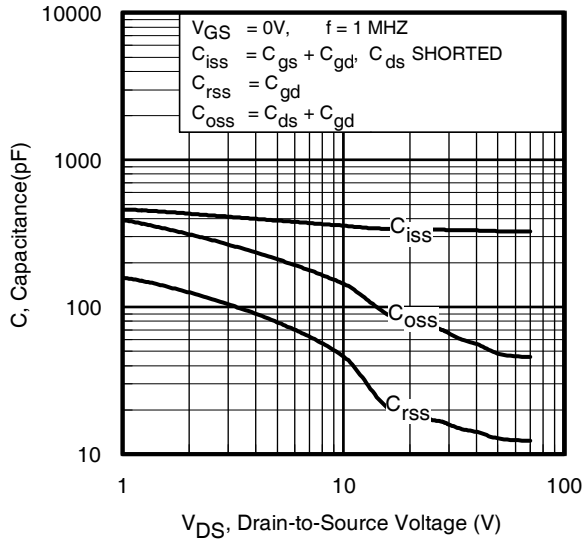
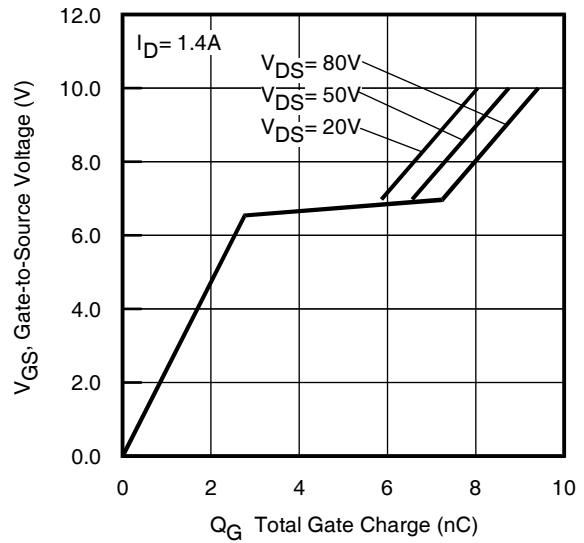


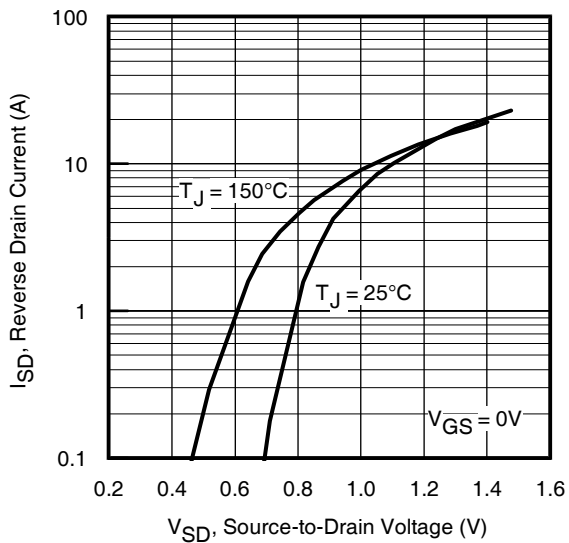
Fig 4. Normalized On-Resistance vs. Temperature



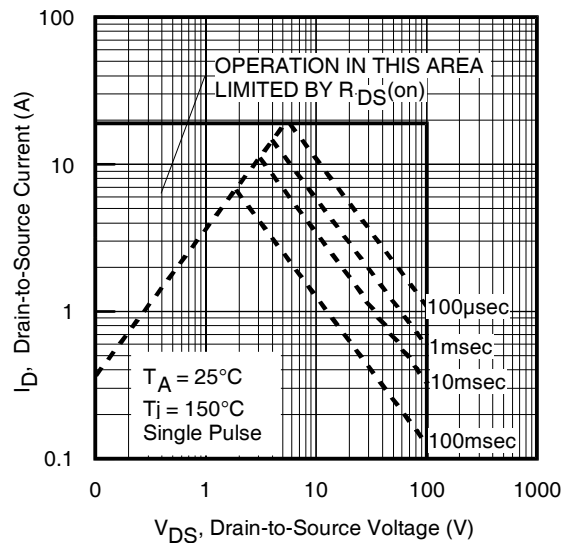
**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage



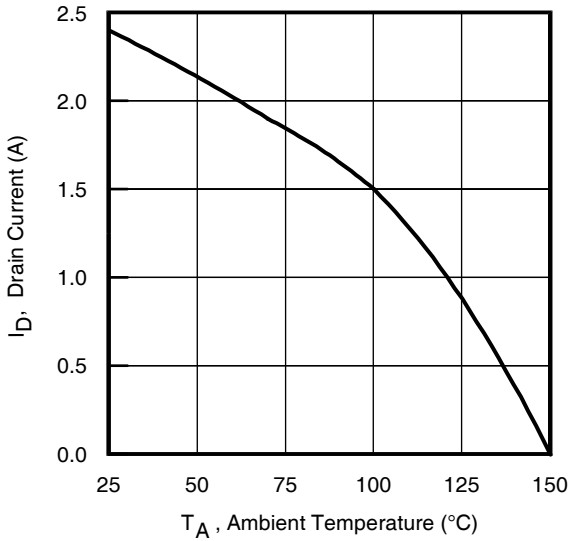
**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage



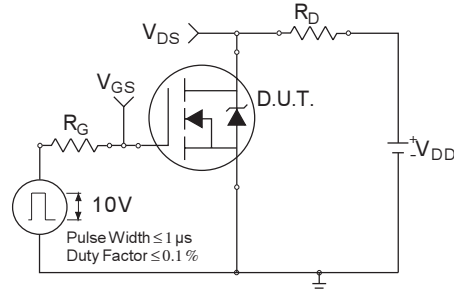
**Fig 7.** Typical Source-Drain Diode Forward Voltage



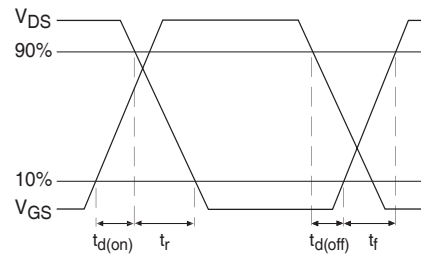
**Fig 8.** Maximum Safe Operating Area



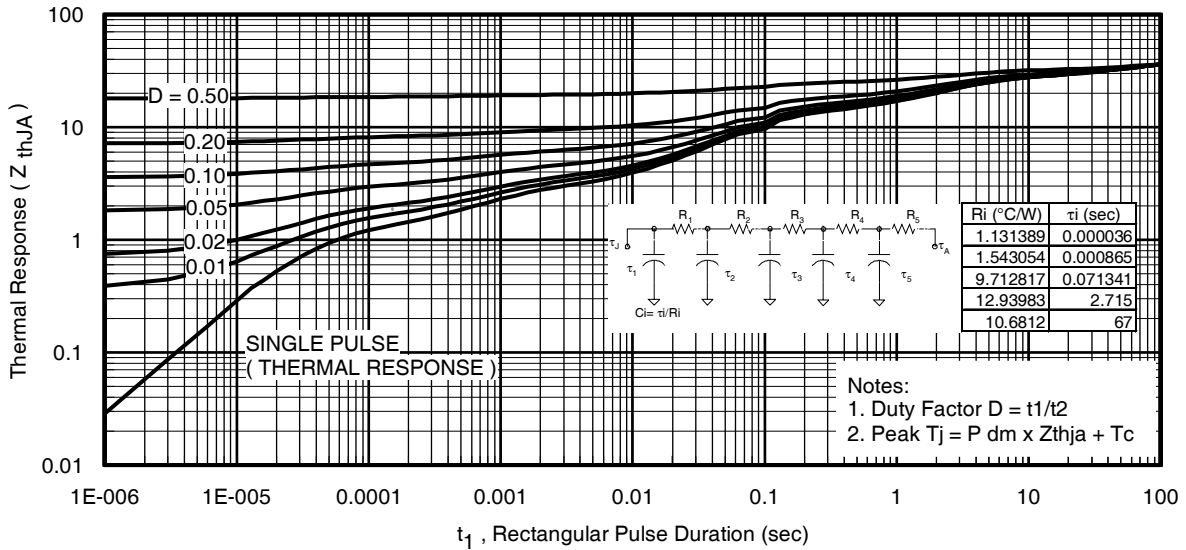
**Fig 9.** Maximum Drain Current vs. Ambient Temperature



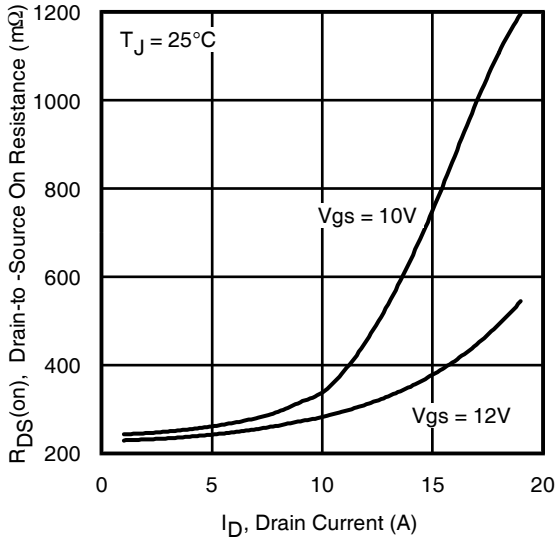
**Fig 10a.** Switching Time Test Circuit



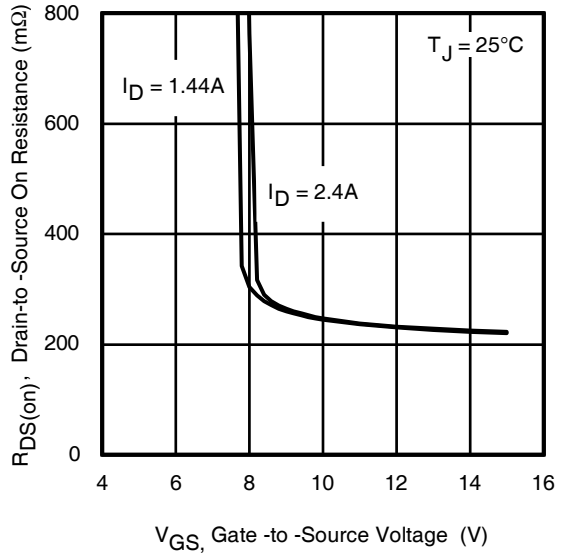
**Fig 10b.** Switching Time Waveforms



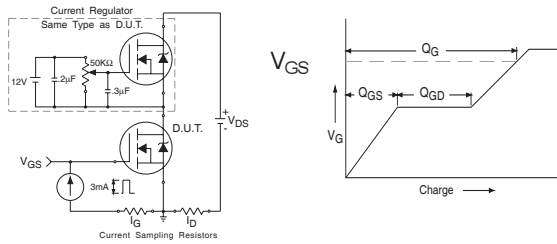
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



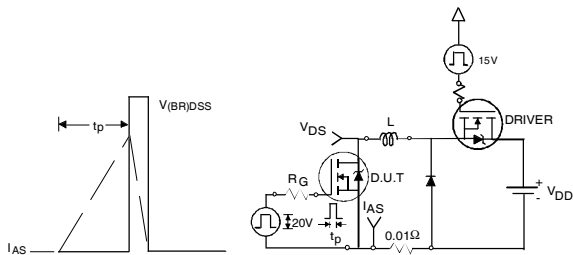
**Fig 12.** On-Resistance vs. Drain Current



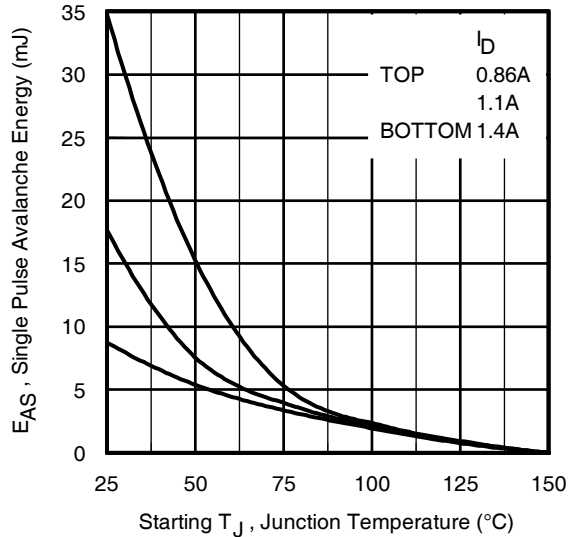
**Fig 13.** On-Resistance vs. Gate Voltage



**Fig 14a&b.** Basic Gate Charge Test Circuit and Waveform

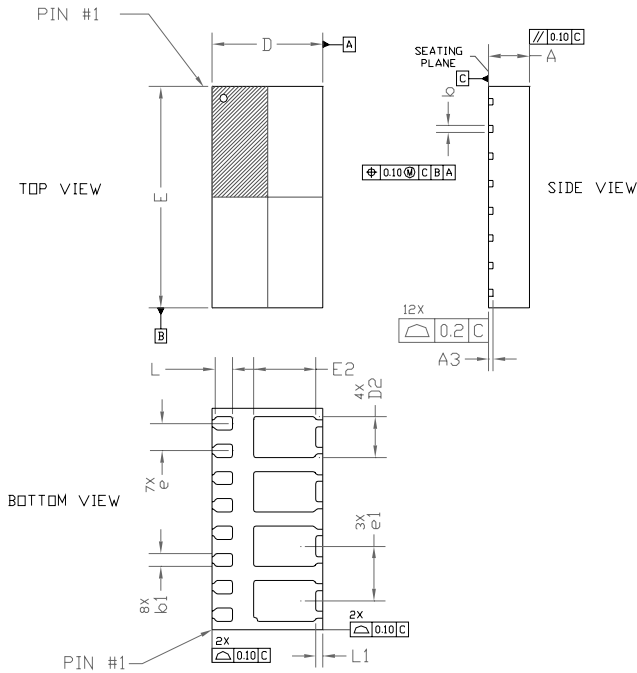


**Fig 15a&b.** Unclamped Inductive Test circuit and Waveforms



**Fig 15c.** Maximum Avalanche Energy vs. Drain Current

IRF4000 Power MLP Package Outline Drawing



SYMBOL	COMMON					
	DIMENSIONS MILLIMETER			DIMENSIONS INCH		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	1.80	1.85	1.90	0.071	0.073	0.075
A3	0.20 BSC.			0.008 BSC.		
b	0.25	0.30	0.35	0.010	0.012	0.014
b1	0.55	0.60	0.65	0.022	0.024	0.026
D	5.00 BSC			0.197 BSC		
D2	1.785	1.835	1.885	0.070	0.072	0.074
E	10.00 BSC			0.394 BSC		
E2	2.755	2.805	2.855	0.108	0.110	0.112
e	1.235 BSC			0.049 BSC		
e1	2.47 BSC			0.097 BSC		
L	0.75	0.80	0.85	0.029	0.031	0.033
L1	0.261	0.311	0.361	0.010	0.012	0.014

NOTES :  
 1. DIMENSION AND TOLERANCING CONFORM TO ASME Y14.5M-1994.  
 2. CONTROLLING DIMENSIONS : MILLIMETER. CONVERTED INCH DIMENSION ARE NOT NECESSARILY EXACT.

**Notes:**

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 8.4\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 1.4\text{A}$ .
- ③ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④ When mounted on 1 inch square copper board.
- ⑤ Guarantee by Design.

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Industrial market.  
 Qualification Standards can be found on IR's Web site.